


Search Notes 	Application/Control No. 10550619	Applicant(s)/Patent Under Reexamination TANAKA ET AL.
	Examiner Heyman, John	Art Unit 2871

SEARCHED			
Class	Subclass	Date	Examiner
349	15, text seach	06/27/2007	JSH

SEARCH NOTES		
Search Notes	Date	Examiner
Consult Primary Examiner Andrew Schechter	06/27/2007	JSH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner